Notice of References Cited Application/Control No. 10/702,049 Examiner TABASSOM TADAYYON Applicant(s)/Patent Under Reexamination FUKIAGE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,316,167	11-2001	Angelopoulos et al.	430/313
*	В	US-2003/0017694	01-2003	Nguyen et al.	438/637
*	C	US-2003/0003768	01-2003	Cho et al.	438/778
*	D	US-2003/0044621	03-2003	Won et al.	428/446
*	Е	US-2002/0163028	11-2002	Yuan, Zheng	257/303
*	F	US-6,238,160	05-2001	Hwang et al.	414/217
*	G	US-4,951,601	08-1990	Maydan et al.	118/719
*	Η	US-2004/0137169	07-2004	Carollo, Enzo	427/579
*	I	US-6,074,488	06-2000	Roderick et al.	118/728
*	J	US-5,776,834	07-1998	Avanzino et al.	438/692
*	K	US-2004/0147137	07-2004	Hiraiwa et al.	438/778
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
*	U	A. Grill, Journal of Applied Physics 93(2003)1758-1790				
	>	Sang-Yun Lee, Journal of Electrochemical Society, 150(1)G58-G61(2003).				
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.